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SEMICONDUCTOR WAFER IDENTIFICATION

Abstract of the Disclosure

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A semiconductor wafer (10), a method of providing information on a semiconductor wafer (10), a system of semiconductor wafer (10) and reading means, and a method of reading information from a semiconductor wafer (10) are provided. The invention is characterized by magnetic means (14) as information carrier and the respective magnetic sensors (26) to read such information.

(Fig. 5)